

N-Channel Enhancement Mode MOSFET

● Features

- $R_{DS(ON)}=37m\Omega @V_{GS}=10V$
- $R_{DS(ON)}=49m\Omega @V_{GS}=4.5V$
- $R_{DS(ON)}=52m\Omega @V_{GS}=2.5V$
- Super high density cell design for extremely low $R_{DS(ON)}$
- Exceptional on-resistance and maximum DC current capability

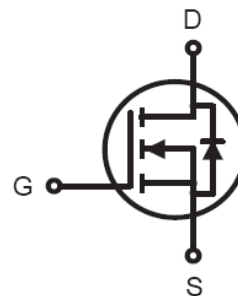
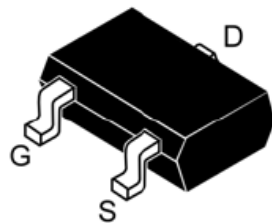
● General Description

The FS2306A is the N-Channel logic enhancement mode power field effect transistors, using high cell density, DMOS trench technology.

This high density process is especially tailored to minimize on-state resistance.

These devices are particularly suited for low voltage application such as cellular phone, notebook computer power management and other battery powered circuits, and low in-line power loss that are needed in a very small outline surface mount package.

● Pin Configurations



SOT23

● Absolute Maximum Ratings @ $T_A=25^\circ C$ unless otherwise noted

Parameter	Symbol	5 secs	Steady State	Units	
Drain-Source Voltage	V_{DS}	30		V	
Gate-Source Voltage	V_{GS}	± 12		V	
Continuous Drain Current ($t_J=150$) ^{a,b}	I_D	$T_A=25^\circ C$	4.0	3.16	A
		$T_A=70^\circ C$	3.5	2.7	
Pulsed Drain Current	I_{DM}	20		A	
Continuous Source Current (Diode Conduction) ^{a,b}	I_S	1.04	0.62	A	
Power Dissipation ^{a,b}	P_D	$T_A=25^\circ C$	1.25	0.75	W
		$T_A=70^\circ C$	0.8	0.48	
Operating Junction Temperature	T_J	-55 to 150		$^\circ C$	

FS2306A

● Thermal Resistance Ratings

Parameter		Symbol	Limits		Units
			Typ	Max	
Maximum Junction-to-Ambient	T 5sec	R_{thJA}	80	100	$^{\circ}C/W$
	Steady-State		130	166	
Maximum Junction-to-Foot(Drain)	Steady-State	R_{thJF}	60	75	$^{\circ}C/W$

Notes

- Surface Mounted on FR4 Board, $t \leq 5$ sec.
- Pulse width limited by maximum junction temperature.

● Electrical Characteristics @ $T_A=25^{\circ}C$ unless otherwise noted

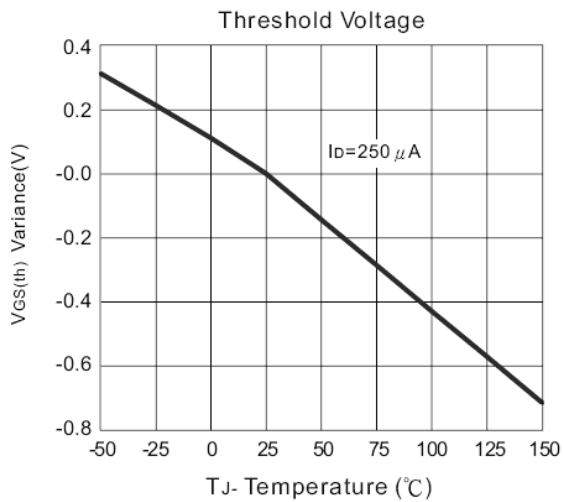
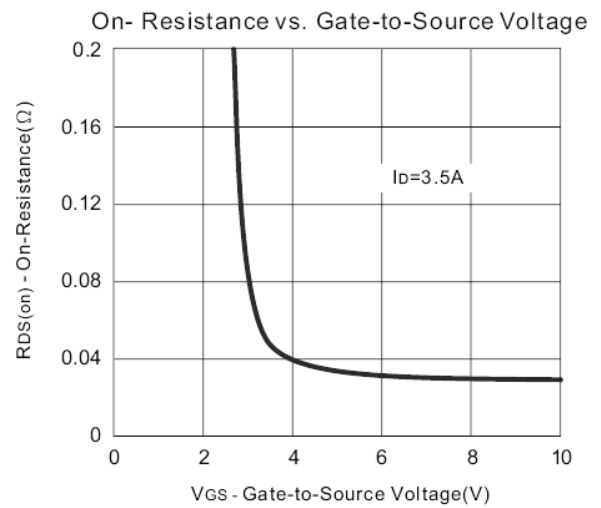
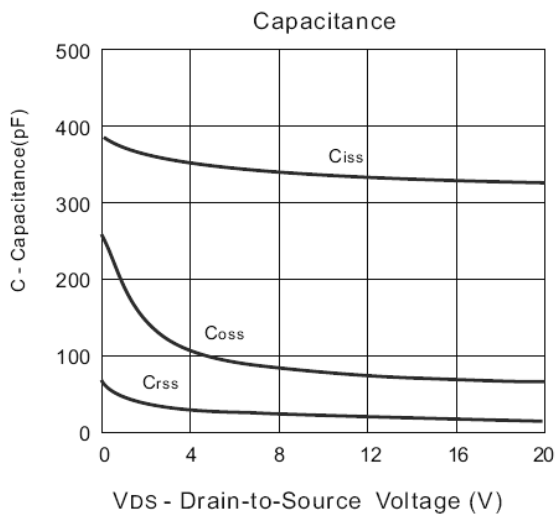
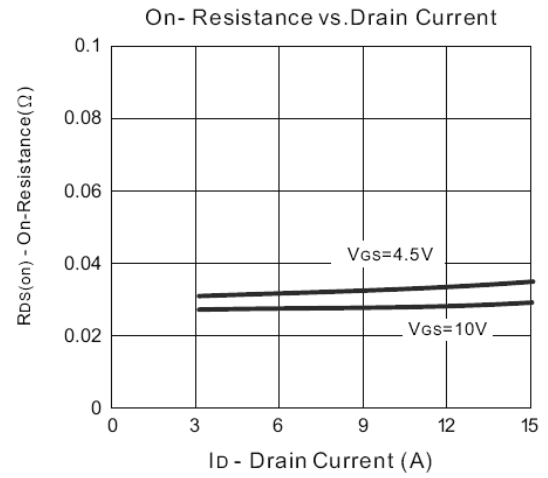
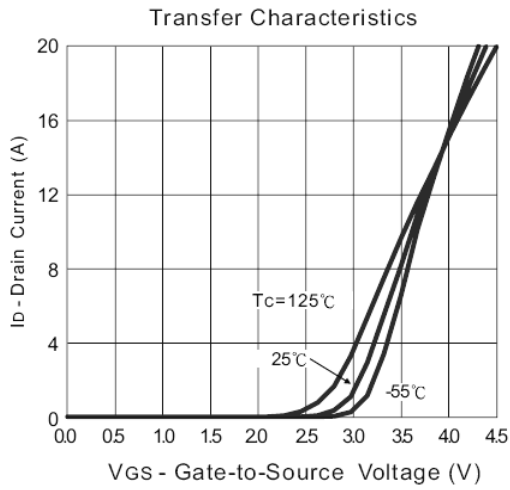
Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 10A$	30			V
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250A$	0.7		1.4	V
I_{GSS}	Gate-Body Leakage	$V_{DS} = 0V, V_{GS} = 20V$			100	nA
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 30V, V_{GS} = 0V$			0.5	A
		$V_{DS} = 30V, V_{GS} = 0V, T = 55^{\circ}C$			10	A
$I_{D(ON)}$	On-State Drain Current ^a	$V_{DS} = 4.5V, V_{GS} = 10V$	6			A
$R_{DS(ON)}$	Drain-Source On-Resistance ^a	$V_{GS} = 10V, I_D = 4.0A$		28	37	m Ω
		$V_{GS} = 4.5V, I_D = 3.5A$		36	49	
		$V_{GS} = 2.5V, I_D = 2.8A$		38	55	
V_{SD}	Diode Forward Voltage	$I_S = 1.25A, V_{GS} = 0V$		0.8	1.2	V
DYNAMIC PARAMETERS						
Q_g	Total Gate Charge	$V_{DS} = 15V, V_{GS} = 10V, I_D = 2.5A$		10.6	15	nC
Q_{gs}	Gate Source Charge			3.2		
Q_{gd}	Gate-Drain Charge			1		
R_g	Gate Resistance	$f = 1.0MHz$		0.72		Ω
$t_{d(on)}$	Turn-On Time	$V_{DD} = 15V, R_L = 15\Omega, I_D = 1A,$ $V_{GEN} = 10V, R_G = 6\Omega$		7.4	15	nS
t_r				13.2	20	
$t_{d(off)}$	Turn-Off Time			21.6	31	
t_f				3.5	9	

Notes

- Pulse test: $PW \leq 300\mu s$ duty cycle $\leq 2\%$.

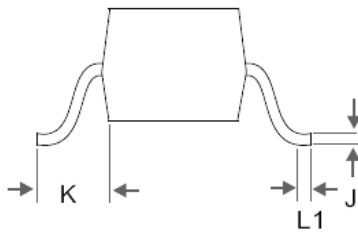
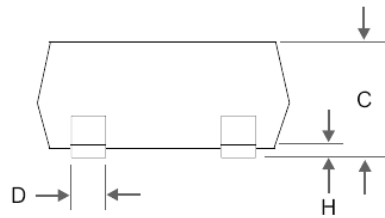
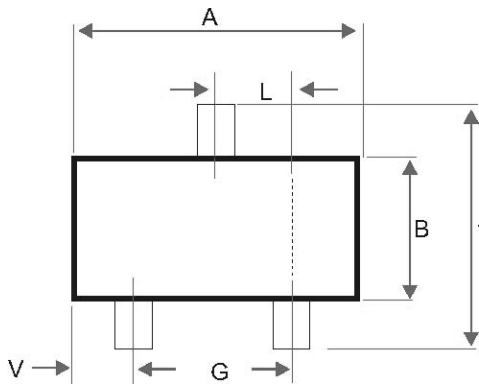
FS2306A

● **Typical Performance Characteristics** (T_J =25 Noted)



FS2306A

- Package Information



DIM	MILLIMETERS	
	MIN	MAX
A	2.80	3.1
B	1.20	1.7
C	0.89	1.3
D	0.37	0.50
G	1.78	2.04
H	0.013	0.15
J	0.085	0.2
K	0.45	0.7
L	0.89	1.02
S	2.10	3
V	0.45	0.60
L1	0.2	0.6